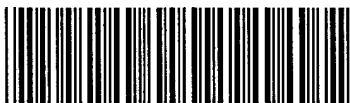


Search Notes

Application/Control No.

10/644,966

Examiner

Lois Zheng

Applicant(s)/Patent under
Reexamination

NAKAZAWA ET AL.

Art Unit

1742

SEARCHED

Class	Subclass	Date	Examiner
204	263	9/27/2006	LLZ
204	271	9/27/2006	LLZ
204	276	9/27/2006	LLZ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventorship Search	9/28/2006	LLZ
Updated EAST Search	9/27/2006	LLZ